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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of:

	Gordhan Barevadia	Docket No.:	TI-36281
Serial No:	10/667,879	Art Unit:	2138
Filed:	09/22/2003	Examiner:	Phung M. Chung
Customer No.:	23494	Conf. No.:	1157
Title: Mechanism to Enhance Observability of Integrated Circuit Failures During Burn-In Tests			

CERTIFICATION OF FACSIMILE TRANSMISSION

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Date

FACSIMILE COVER SHEET

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<input type="checkbox"/> CONTINUATION APP'N (# Pages)	
<input type="checkbox"/> DIVISIONAL APP'N	
NAME OF INVENTOR(S): Gordhan Barevadia	
RECEIPT DATE & SERIAL NO.: Serial No.: 10/667,879	
TITLE OF INVENTION: Mechanism to Enhance Observability of Integrated Circuit Failures During Burn-In Tests	
TI FILE NO.: TI-36281	DEPOSIT ACCT. NO.: 20-0668
FAXED: 4/3/2006 DUE: 4/24/2006 ATTY/SECY: AZ/ms	

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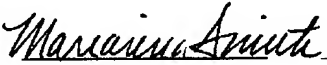
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Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

AMENDMENT PURSUANT TO 37 CFR 1.111

Dear Sir:

This amendment is in response to the Office Action dated January 24, 2006, having a statutory period for response set to expire on April 24, 2006.

Amendments to the Specification begin on page 2.

Amendments to Claims begin on page 3.

Remarks/Arguments begin on page 6.

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